TEST LOG



Article number: 135026WS001	Sprache Language ODE	OEN OFR ONL OES OPL
Internal number:	Serial number:	Date: 29.11.2022
Device status:	Bemerkungen / Re	emarks:
As good as new unused		
 Damaged (light) technically inspected 		
Damaged (dents/scratches) technically checke	d	
Signs of wear (light) technically checked		
Traces of use technically checked		
Product Specific Information		
VDE test conducted: YES		NECESSARY
Device complete: YES	ΝΟ	
All functions tested: YES	ΝΟ	
Device cleaned: YES	ΝΟ	
Packaging:		
Original packaging		

• Original packaging (damaged)

Substitute packaging

Picture 1



TEST LOG | A-LAGER



Picture 2



Picture 3



TEST LOG | A-LAGER

Picture 4







Picture 6

